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|-----------------------------------|---------------------------------------|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>09/801,951 | Applicant(s)/Patent Under<br>Reexamination<br>DURR ET AL. |             |
|                                   | Examiner<br>Wei Y. Zhen               | Art Unit<br>2191  | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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